## International IOR Rectifier

### **AUTOMOTIVE GRADE**

# AUIRFS3306

HEXFET® Power MOSFET

#### **Features**

- Advanced Process Technology
- Ultra Low On-Resistance
- Dynamic dv/dt Rating
- 175°C Operating Temperature
- Fast Switching
- Repetitive Avalanche Allowed up to Tjmax
- Lead-Free, RoHS Compliant
- Automotive Qualified \*

112/11/21	WOI WIOOI E I
V <sub>DSS</sub>	60V
R <sub>DS(on)</sub> typ.	$3.3$ m $\Omega$
max.	$4.2$ m $\Omega$
I <sub>D (Silicon Limited)</sub>	160A ①
I <sub>D (Package Limited)</sub>	120A



G	D	S
Gate	Drain	Source

### **Description**

Specifically designed for Automotive applications, this HEXFET® Power MOSFET utilizes the latest processing techniques to achieve extremely low on-resistance per silicon area. Additional features of this design are a 175°C junction operating temperature, fast switching speed and improved repetitive avalanche rating. These features combine to make this design an extremely efficient and reliable device for use in Automotive applications and a wide variety of other applications.

### **Absolute Maximum Ratings**

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only; and functional operation of the device at these or any other condition beyond those indicated in the specifications is not implied. Exposure to absolutemaximum-rated conditions for extended periods may affect device reliability. The thermal resistance and power dissipation ratings are measured under board mounted and still air conditions. Ambient temperature (TA) is 25°C, unless otherwise specified.

Symbol	Parameter	Max.	Units
I <sub>D</sub> @ T <sub>C</sub> = 25°C	Continuous Drain Current, V <sub>GS</sub> @ 10V (Silicon Limited)	160①	
I <sub>D</sub> @ T <sub>C</sub> = 100°C	Continuous Drain Current, V <sub>GS</sub> @ 10V (Silicon Limited)	110①	٦ ,
I <sub>D</sub> @ T <sub>C</sub> = 25°C	Continuous Drain Current, V <sub>GS</sub> @ 10V (Wire Bond Limited)	120	A
I <sub>DM</sub>	Pulsed Drain Current ②	620	
P <sub>D</sub> @T <sub>C</sub> = 25°C	Maximum Power Dissipation	230	W
	Linear Derating Factor	1.5	W/°C
$V_{GS}$	Gate-to-Source Voltage	± 20	V
E <sub>AS</sub>	Single Pulse Avalanche Energy (Thermally Limited) 3	184	mJ
I <sub>AR</sub>	Avalanche Current ②	See Fig. 14, 15, 22a, 22b	Α
E <sub>AR</sub>	Repetitive Avalanche Energy ②		mJ
dv/dt	Peak Diode Recovery ④	14	V/ns
$T_J$	Operating Junction and	-55 to + 175	
T <sub>STG</sub>	Storage Temperature Range		°C
	Soldering Temperature, for 10 seconds	300	7
	(1.6mm from case)		

#### **Thermal Resistance**

Symbol	Parameter	Тур.	Max.	Units
$R_{\theta JC}$	Junction-to-Case ®		0.65	°C/W
$R_{\theta JA}$	Junction-to-Ambient (PCB Mount) ®		40	0/ **

HEXFET® is a registered trademark of International Rectifier.

<sup>\*</sup>Qualification standards can be found at http://www.irf.com/

### Static Electrical Characteristics @ T<sub>J</sub> = 25°C (unless otherwise specified)

Symbol	Parameter	Min.	Тур.	Max.	Units	Conditions
$V_{(BR)DSS}$	Drain-to-Source Breakdown Voltage	60			V	$V_{GS} = 0V, I_D = 250\mu A$
$\Delta V_{(BR)DSS}/\Delta T_{J}$	Breakdown Voltage Temp. Coefficient		0.07		V/°C	Reference to 25°C, I <sub>D</sub> = 5mA <sup>©</sup>
R <sub>DS(on)</sub>	Static Drain-to-Source On-Resistance		3.3	4.2	mΩ	$V_{GS} = 10V, I_D = 75A $ ⑤
V <sub>GS(th)</sub>	Gate Threshold Voltage	2.0		4.0	V	$V_{DS} = V_{GS}$ , $I_D = 150\mu A$
gfs	Forward Transconductance	230			S	$V_{DS} = 50V, I_{D} = 75A$
$R_G$	Internal Gate Resistance		0.7		Ω	
I <sub>DSS</sub>	Drain-to-Source Leakage Current			20	μΑ	$V_{DS} = 60V$ , $V_{GS} = 0V$
				250		$V_{DS} = 48V, V_{GS} = 0V, T_{J} = 125^{\circ}C$
I <sub>GSS</sub>	Gate-to-Source Forward Leakage			100	nA	$V_{GS} = 20V$
	Gate-to-Source Reverse Leakage			-100		$V_{GS} = -20V$

### Dynamic Electrical Characteristics @ T<sub>.I</sub> = 25°C (unless otherwise specified)

Symbol	Parameter	Min.	Тур.	Max.	Units	Conditions
$Q_g$	Total Gate Charge		85	120	nC	I <sub>D</sub> = 75A
$Q_{gs}$	Gate-to-Source Charge		20			$V_{DS} = 30V$
$Q_{gd}$	Gate-to-Drain ("Miller") Charge		26			V <sub>GS</sub> = 10V ⑤
Q <sub>sync</sub>	Total Gate Charge Sync. (Q <sub>g</sub> - Q <sub>gd</sub> )		59			$I_D = 75A, V_{DS} = 0V, V_{GS} = 10V$
t <sub>d(on)</sub>	Turn-On Delay Time		15		ns	$V_{DD} = 30V$
t <sub>r</sub>	Rise Time		76			$I_D = 75A$
t <sub>d(off)</sub>	Turn-Off Delay Time		40			$R_G = 2.7\Omega$
t <sub>f</sub>	Fall Time		77			V <sub>GS</sub> = 10V ⑤
C <sub>iss</sub>	Input Capacitance		4520		pF	$V_{GS} = 0V$
C <sub>oss</sub>	Output Capacitance		500		1	$V_{DS} = 50V$
C <sub>rss</sub>	Reverse Transfer Capacitance		250		1	f = 1.0MHz, See Fig. 5
C <sub>oss</sub> eff. (ER)	Effective Output Capacitance (Energy Related)		720			$V_{GS} = 0V$ , $V_{DS} = 0V$ to 48V $\odot$ , See Fig. 11
C <sub>oss</sub> eff. (TR)	Effective Output Capacitance (Time Related) ®		880		1	$V_{GS} = 0V$ , $V_{DS} = 0V$ to 48V ®

### **Diode Characteristics**

Symbol	Parameter	Min.	Тур.	Max.	Units	Conditions
I <sub>S</sub>	Continuous Source Current			160①	Α	MOSFET symbol
	(Body Diode)					showing the
I <sub>SM</sub>	Pulsed Source Current			620	Α	integral reverse
	(Body Diode) ②					p-n junction diode.
$V_{SD}$	Diode Forward Voltage			1.3	V	$T_J = 25^{\circ}C$ , $I_S = 75A$ , $V_{GS} = 0V$ $\$$
t <sub>rr</sub>	Reverse Recovery Time		31		ns	$T_J = 25^{\circ}C$ $V_R = 51V$ ,
			35		l	$T_J = 125$ °C $I_F = 75A$
Q <sub>rr</sub>	Reverse Recovery Charge		34		nC	$T_J = 25^{\circ}C$ di/dt = 100A/ $\mu$ s $\odot$
			45			$T_J = 125$ °C
I <sub>RRM</sub>	Reverse Recovery Current		1.9		Α	$T_J = 25^{\circ}C$
t <sub>on</sub>	Forward Turn-On Time	Intrins	Intrinsic turn-on time is negligible (turn-on is dominated by LS+LD)			

### Notes:

- ① Calculated continuous current based on maximum allowable junction ④  $I_{SD} \le 75A$ , di/dt  $\le 1400A/\mu s$ ,  $V_{DD} \le V_{(BR)DSS}$ ,  $T_J \le 175^{\circ}C$ . temperature. Bond wire current limit is 120A. Note that current limitations arising from heating of the device leads may occur with some lead mounting arrangements.
- ② Repetitive rating; pulse width limited by max. junction temperature.
- $R_G$  = 25  $\!\Omega,\,I_{AS}$  = 96 A,  $V_{GS}$  =10 V. Part not recommended for use above this value.
- ⑤ Pulse width  $\leq 400\mu s$ ; duty cycle  $\leq 2\%$ .
- $\ \, \mbox{\ensuremath{\mathbb{G}}} \ \, \mbox{\ensuremath{\mathbb{C}}}_{\mbox{\scriptsize oss}} \ \mbox{\scriptsize eff.} \ \mbox{\scriptsize (TR)}$  is a fixed capacitance that gives the same charging time as  $C_{oss}$  while  $V_{DS}$  is rising from 0 to 80%  $V_{DSS}$ .
- O Coss eff. (ER) is a fixed capacitance that gives the same energy as  $C_{oss}$  while  $V_{DS}$  is rising from 0 to 80%  $V_{DSS}$ .
- ® When mounted on 1" square PCB (FR-4 or G-10 Material). For recom mended footprint and soldering techniques refer to application note #AN-994.

### Qualification Information<sup>†</sup>

			Automotive (per AEC-Q101) ††				
Qualification Le	vel	qualification.	Comments: This part number(s) passed Automotive qualification. IR's Industrial and Consumer qualification level is granted by extension of the higher Automotive level.				
Moisture Sensit	ivity Level	D <sup>2</sup> Pak	D <sup>2</sup> Pak MSL1				
	Machine Model  Human Body Model		Class M4 (+/- >800V) <sup>†††</sup> AEC-Q101-002				
ESD			Class H2 (+/- 3000V) <sup>†††</sup> AEC-Q101-001				
	Charged Device Model		Class C5 (+/- >2000V) <sup>†††</sup> AEC-Q101-005				
RoHS Complian	t	Yes					

<sup>†</sup> Qualification standards can be found at International Rectifier's web site: http://www.irf.com/

<sup>††</sup> Exceptions (if any) to AEC-Q101 requirements are noted in the qualification report.

<sup>†††</sup> Highest passing voltage.

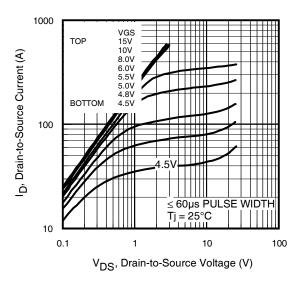


Fig 1. Typical Output Characteristics

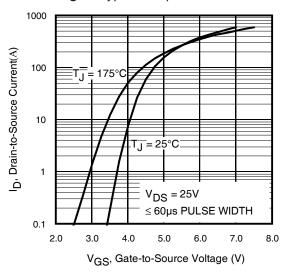


Fig 3. Typical Transfer Characteristics

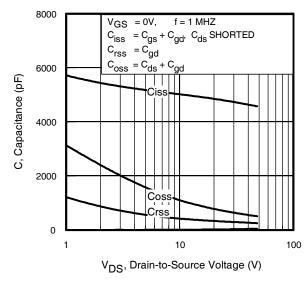


Fig 5. Typical Capacitance vs. Drain-to-Source Voltage

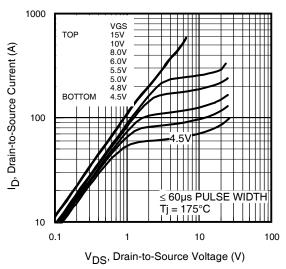


Fig 2. Typical Output Characteristics

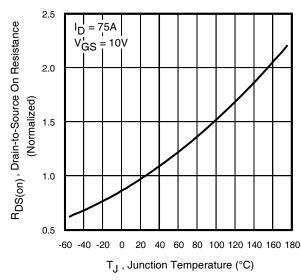
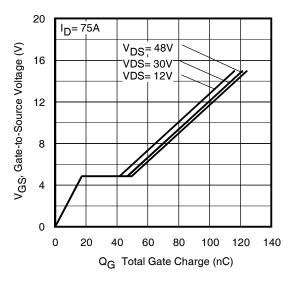
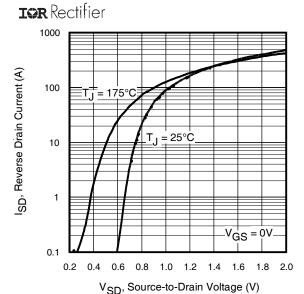


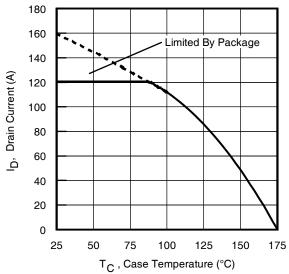
Fig 4. Normalized On-Resistance vs. Temperature



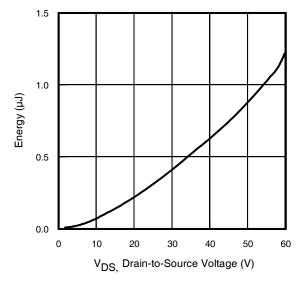
**Fig 6.** Typical Gate Charge vs. Gate-to-Source Voltage www.irf.com



**Fig 7.** Typical Source-Drain Diode Forward Voltage



**Fig 9.** Maximum Drain Current vs. Case Temperature



**Fig 11.** Typical C<sub>OSS</sub> Stored Energy www.irf.com

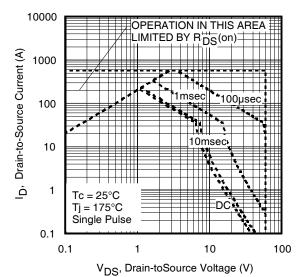


Fig 8. Maximum Safe Operating Area

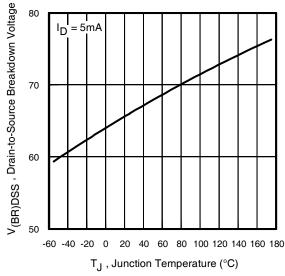


Fig 10. Drain-to-Source Breakdown Voltage

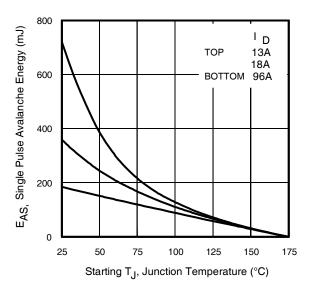


Fig 12. Maximum Avalanche Energy Vs. DrainCurrent

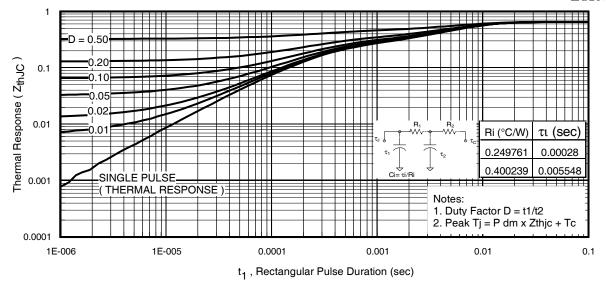


Fig 13. Maximum Effective Transient Thermal Impedance, Junction-to-Case

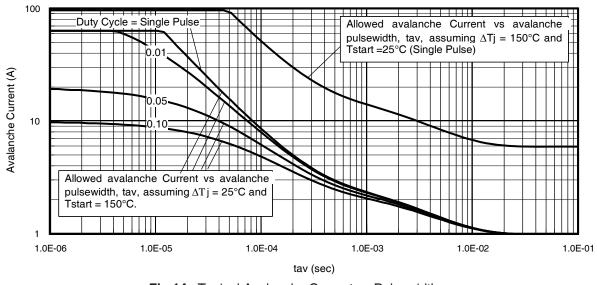


Fig 14. Typical Avalanche Current vs. Pulsewidth

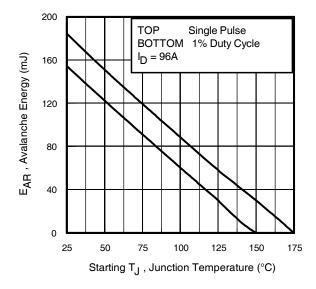


Fig 15. Maximum Avalanche Energy vs. Temperature

## Notes on Repetitive Avalanche Curves , Figures 14, 15: (For further info, see AN-1005 at www.irf.com)

1. Avalanche failures assumption:

Purely a thermal phenomenon and failure occurs at a temperature far in excess of  $T_{jmax}$ . This is validated for every part type.

- 2. Safe operation in Avalanche is allowed as long asT<sub>imax</sub> is not exceeded.
- 3. Equation below based on circuit and waveforms shown in Figures 16a, 16b.
- 4.  $P_{D (ave)}$  = Average power dissipation per single avalanche pulse.
- BV = Rated breakdown voltage (1.3 factor accounts for voltage increase during avalanche).
- 6. I<sub>av</sub> = Allowable avalanche current.
- 7.  $\Delta T$  = Allowable rise in junction temperature, not to exceed  $T_{jmax}$  (assumed as 25°C in Figure 14, 15).

t<sub>av =</sub> Average time in avalanche.

D = Duty cycle in avalanche =  $t_{av} \cdot f$ 

 $Z_{th,JC}(D, t_{av})$  = Transient thermal resistance, see Figures 13)

$$\begin{split} P_{D \; (ave)} &= 1/2 \; (\; 1.3 \cdot BV \cdot I_{av}) = \triangle T / \; Z_{thJC} \\ I_{av} &= 2\triangle T / \; [1.3 \cdot BV \cdot Z_{th}] \\ E_{AS \; (AR)} &= P_{D \; (ave)} \cdot t_{av} \end{split}$$

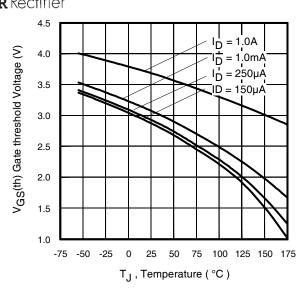


Fig 16. Threshold Voltage Vs. Temperature

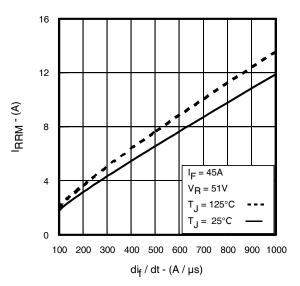


Fig. 18 - Typical Recovery Current vs. dif/dt

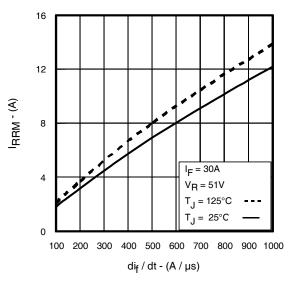


Fig. 17 - Typical Recovery Current vs. di<sub>f</sub>/dt

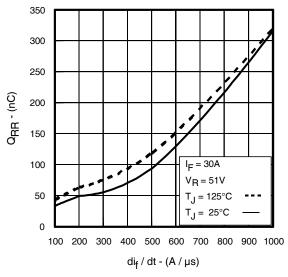


Fig. 19 - Typical Stored Charge vs. dif/dt

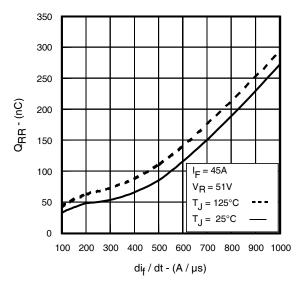


Fig. 20 - Typical Stored Charge vs. dif/dt

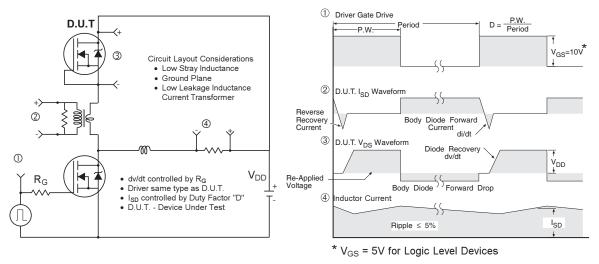


Fig 21. Peak Diode Recovery dv/dt Test Circuit for N-Channel

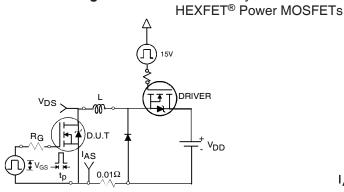


Fig 22a. Unclamped Inductive Test Circuit

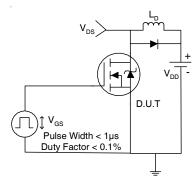


Fig 23a. Switching Time Test Circuit

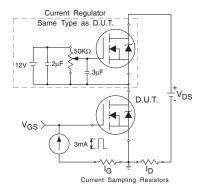


Fig 24a. Gate Charge Test Circuit

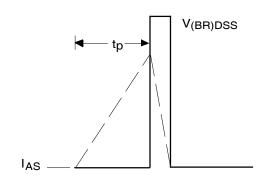


Fig 22b. Unclamped Inductive Waveforms

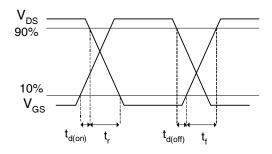


Fig 23b. Switching Time Waveforms

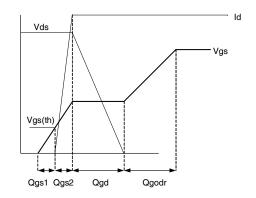
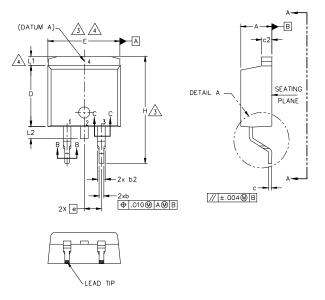
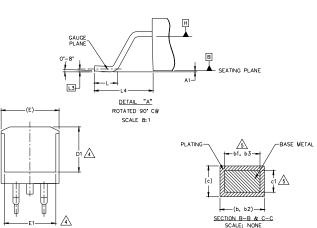


Fig 24b. Gate Charge Waveform

## $D^2Pak\ Package\ Outline\ (Dimensions\ are\ shown\ in\ millimeters\ (inches))$





S	DIMENSIONS					
M B O	MILLIM	ETERS	INC	HES	O T E S	
L	MIN.	MAX.	MIN.	MAX.	S S	
Α	4.06	4.83	.160	.190		
A1	0.00	0.254	.000	.010		
Ь	0.51	0.99	.020	.039		
ь1	0.51	0.89	.020	.035	5	
b2	1,14	1.78	.045	.070		
b3	1.14	1.73	.045	.068	5	
С	0.38	0.74	.015	.029		
c1	0.38	0.58	.015	.023	5	
c2	1,14	1.65	.045	.065		
D	8.38	9.65	.330	.380	3	
D1	6.86	-	.270		4	
E	9.65	10.67	.380	.420	3,4	
E1	6.22	_	.245		4	
е	2.54	BSC	.100	BSC		
Н	14.61	15.88	.575	.625		
L	1.78	2.79	.070	.110		
L1	-	1.65	_	.066	4	
L2	1.27	1.78	_	.070		
L3	0.25	BSC	.010	,010 BSC		
L4	4.78	5.28	.188	.208		

#### LEAD ASSIGNMENTS

#### DIODES

1.- ANODE (TWO DIE) / OPEN (ONE DIE) 2, 4.- CATHODE 3.- ANODE

<u>HEXFET</u>

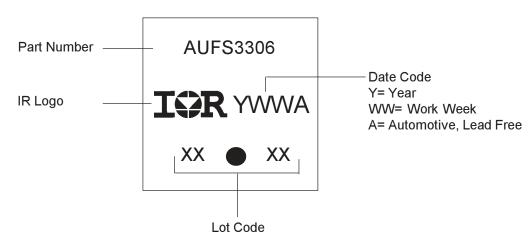
IGBTs, CoPACK

1.- GATE 2, 4.- DRAIN 3.- SOURCE 1.- GATE 2, 4.- COLLECTOR 3.- EMITTER

#### NOTES:

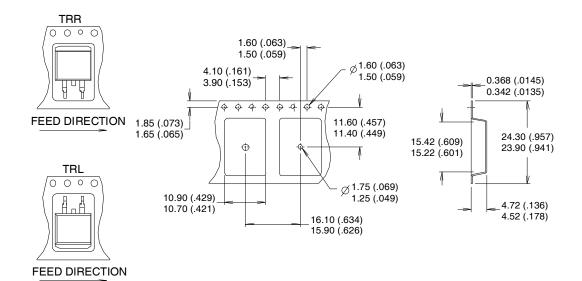
- 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994
- 2. DIMENSIONS ARE SHOWN IN MILLIMETERS [INCHES].
- 3 DIMENSION D & E DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED 0.127 [.005"] PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTMOST EXTREMES OF THE PLASTIC BODY AT DATUM H.
- 4. THERMAL PAD CONTOUR OPTIONAL WITHIN DIMENSION E, L1, D1 & E1.
- 5. DIMENSION 61 AND c1 APPLY TO BASE METAL ONLY.
- 6. DATUM A & B TO BE DETERMINED AT DATUM PLANE H.
- 7. CONTROLLING DIMENSION: INCH.
- 8. OUTLINE CONFORMS TO JEDEC OUTLINE TO-263AB.

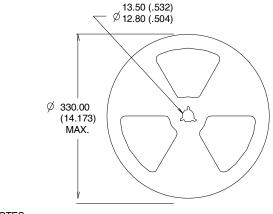
### D<sup>2</sup>Pak Part Marking Information

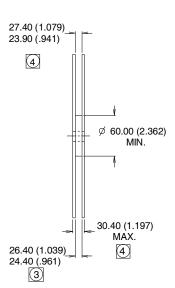


Note: For the most current drawing please refer to IR website at: http://www.irf.com/package/

### D<sup>2</sup>Pak Tape & Reel Information







NOTES:

- 1. COMFORMS TO EIA-418.
- 2. CONTROLLING DIMENSION: MILLIMETER.
- 3 DIMENSION MEASURED @ HUB.
- INCLUDES FLANGE DISTORTION @ OUTER EDGE.

### **Ordering Information**

Base part number	Package Type	Standard Pack		Complete Part Number
		Form	Quantity	
AUIRFS3306	D2Pak	Tube	50	AUIRFS3306
		Tape and Reel Left	800	AUIRFS3306TRL
		Tape and Reel Right	800	AUIRFS3306TRR

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